PATENT

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re the application of:)
••) Group Art Unit: 2811
BAILEY III et al.)
Application No. 10/760 409) Examiner: Unassigned
Application No. 10/769,498) Atty. Docket No. LAM2P447
Filed: January 30, 2004)
) Date: January 31, 2005
For: STRESS FREE ETCH PROCESSING IN)
COMBINATION WITH A DYNAMIC LIQUID)
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CERTIFICATE OF MAILING

I hereby certify that this correspondence is being deposited with the United States Postal Service as First Class Mail in an envelope addressed to: Commissioner for Patents, P.O. Box 1450 Alexandria, VA 22313-1450 on January 31, 2005.

INFORMATION DISCLOSURE STATEMENT

Commissioner for Patents Alexandria, VA 22313-1450

Dear Sir:

The references listed in the attached PTO Form 1449, a copy of which is attached, may be material to examination of the above-identified patent application. Applicants submit these references in compliance with their duty of disclosure pursuant to 37 CFR §§ 1.56 and 1.97. The Examiner is requested to consider these references and to acknowledge such consideration by initialing the appropriate location on the attached PTO Form 1449.

This Information Disclosure Statement (IDS) is not to be construed as a representation that a search has been made, that additional information material to the examination of this application does not exist, or that these references indeed constitute prior art.

This IDS is believed to be filed before the mailing date of a first Office Action. Accordingly, it is believed that no fees are due in connection with the filing of this IDS. However, if it is determined that any fees are due, then the Commissioner is hereby authorized to charge such fees to Deposit Account 50-0805 (Order No. LAM2P447).

Respectfully submitted,

MARTINE, PENILLA & GENCARELLA, LLP

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Telephone: (408) 774-6923 **Customer Number 25920**

PTO/SB/08A(08-03) Complete if Known Application Number 10/769,498 tite for form 1449/PTO Filing Date January 30, 2004 INFORMATION DISCLOSURE First Named Inventor Bailey STATEMENT BY APPLICANT Art Unit 2811 (Use as many sheets as necessary) **Examiner Name** Unassigned **Attorney Docket Number** LAM2P447 Sheet of

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	M-1	WO 03/058703	Jul 17, 2003	Gotkis et al.		
	N-1	WO 01/88229	Nov 22, 2001	Wang		
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	M-2	JP 07230993	Aug 29, 1995	Hidenobu et al.		
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